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# High Performance and Broadband photodetectors Based on SnS<sub>2</sub>/InSe Heterojunction

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**Abstract:** We reported a broadband photodetector with a spectral range of 365-965 nm, based on a  $SnS_2/InSe$  vertical heterojunction. In this device, InSe serves as the optical absorption layer, effectively extending the spectral range, while  $SnS_2$  functions as the transmission layer, forming a heterojunction with InSe to facilitate separation of electron-hole pairs and enhance the responsivity. The photodetector exhibits a responsivity of 813 A/W under 365 nm. Moreover, it still maintained a high responsivity of 371 A/W, an external quantum efficiency of  $1.3 \times 10^5\%$ , a specific detectivity of  $3.17 \times 10^{12}$  Jones, and a response time of 27 ms under 965 nm illumination. The above investigation provides a new approach for broadband photodetectors with high responsivity.

Key words: two-dimensional material, heterojunction, Broadband photodetectors

## 基于SnS<sub>2</sub>/InSe异质结的高性能宽带光电探测器

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摘要: 我们报道了一种基于  $SnS_2$  / InSe 垂直异质结的宽带光电探测器,其光谱范围为 365-965 nm。其中, InSe 作为光吸收层,有效扩展了光谱范围,  $SnS_2$ 作为传输层,与 InSe 形成异质结,促进了电子-空穴对的分离,增强了光响应。该光电探测器在 365 nm 下具有 813 A/W 的响应度。并且,在 965nm 光照下它仍然具有 371 A/W 的高响应度,  $1.3\times10^5$ %的外量子效率,  $3.17\times10^{12}$  Jones 的比探测率,以及 27 ms 的响应时间。该研究为高响应宽带光电探测器提供了一种新的方法。

关键词:二维材料;异质结;宽带光电探测器中图分类号:

#### Introduction

Photodetectors play an important role in many fields such as remote sensing, reconnaissance, thermal imaging, and medical imaging. Narrow-spectrum photodetectors are unable to meet the increasingly complex needs of photodetection. The two-dimensional (2D) materials

have received a lot of attention because of their unique structural, electrical and optical properties since the successful exfoliation of graphene in 2004<sup>[1-4]</sup>. Up to now, most of the reported photodetectors based on 2D materials work in a narrow spectral band<sup>[5]</sup>, and there are relatively few reports on broadband photodetectors, which affect the development of 2D material photodetectors. In recent

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years, InSe has been widely reported for its wide adjustable band gap ranging from 1.25 eV for bulk materials to 2. 2 eV for monolayer materials<sup>[6]</sup>. InSe-based photodetectors are very suitable for the detection in the spectral range of 400-1 000 nm<sup>[7,8]</sup>, and InSe has high carrier mobility and small effective mass of electrons [9], all of which indicate that InSe is a promising candidate material for broadband response. However, the reported broadband InSe-based photodetectors have shown relatively low responsivity. For example, the WS<sub>2</sub>/InSe heterojunction photodetector has a responsivity of 61 mA/W under 520 nm illumination<sup>[10]</sup>. The SnSe/InSe heterojunction photodetector has a responsivity of 350 mA/W under 808 nm illumination[11]. SnS, is an environment-friendly material with high carrier mobility, high switching ratio, and strong optical absorption, which makes it very suitable for photoelectric devices<sup>[12, 13]</sup>. However, the drawbacks of narrow spectrum response range of SnS2 and the easy recombination of photogenerated carriers [14] have hindered its development. By combining the advantages of these two materials, it's promising to construct a broadband.

In this work, a SnS<sub>2</sub>/InSe vertical structure photodetector was prepared, in which InSe was used as the photo absorption layer and SnS2 was used as the transmission layer. By building a Van der Waals (vdW) heterojunction to form an effective type-II energy band alignment structure, the electron-hole pairs can be separated effectively to extend the carrier lifetime and improve the responsivity. The device had excellent responsivity in the 365-965 nm range, whose responsivity reached 813 A/W under 365 nm illumination with gate voltage modulation. Under the same gate voltage, a maximum responsivity of 371 A/ W under 965 nm illumination, which was much higher than other reported broadband photodetectors [15], was obtained. And the device had a specific detectivity of 3, 17× 10<sup>12</sup> Jones, a high external quantum efficiency of 1. 3× 10<sup>5</sup>% and a response time of 27 ms. These results demonstrate the successful preparation of a broadband SnS<sub>2</sub>/InSe heterostructure photodetector with high performance.

## 2 Experimental section

## 2. 1 Device fabrication

The SnS<sub>2</sub>/InSe heterojunction device was fabricated on SiO<sub>2</sub>/ Si substrates using a dry transfer technique. Firstly, few-layer flakes of SnS<sub>2</sub> and InSe were mechanically exfoliated from commercial bulk crystals, and the exfoliated SnS<sub>2</sub> flakes were transferred onto a highly pdoped Si substrate with 300 nm SiO<sub>2</sub>, subsequently. The same approach was then adopted to transfer the exfoliated InSe onto SnS, with the assistance of an optical microscope (OM, BX51, OLMPUS). Finally, electrode patterns were prepared by electron-beam lithography system (EBL, Raith eLINE Plus) and then Ti/Au (10 nm/50 nm) metal stacks were deposited by electron beam evaporation (Ulvac Ei-5z) to form source and drain electrodes. Then Raman spectrometer (LABRAM HR, Japan Horriba-JY) and atomic force microscopy (AFM, Dimension ICON, American Bruker) were used to measure characteristic peaks and heights of materials. The atomic structure features, the composition and element distribution of the heterojunction were analyzed by high-resolution transmission electron microscopy (HRTEM, Talos) and energy dispersive X-ray spectroscopy (EDS), respectively.

#### 2. 2 Result and Discussion

Figure 1(a) shows the schematic diagram of a SnS<sub>2</sub>/ InSe heterojunction photodetector. The mechanically exfoliated SnS, and InSe were sequentially covered on the SiO<sub>2</sub>/Si substrate, and the Ti/Au electrodes were placed on the SnS<sub>2</sub>. Figure 1(b) shows the Raman spectrum of the single SnS<sub>2</sub> and InSe as well as the region where the two were stacked to form a heterojunction. The single SnS, [16] (blue line) had a typical Raman feature main peak  $A_{1g}$  at 313.4 cm<sup>-1</sup>, and the single InSe <sup>[6]</sup> (red line) had four Raman feature peaks at 116 cm<sup>-1</sup>, 178 cm<sup>-1</sup>, 200 cm<sup>-1</sup>, and 227 cm<sup>-1</sup>, corresponding in turn to  $A_1'$ , E " (TO), E" (LO), and A1. All the above peaks were observed in the overlapping region of the SnS<sub>2</sub>/InSe heterojunction (black line), indicating the formation of a Van der Waals heterojunction. The thicknesses of the SnS2 and InSe were measured by AFM, as shown in Figure 1 (c). The thicknesses of SnS<sub>2</sub> and InSe were 12 nm and 10 nm, respectively, and the inset shows the surface topography of the heterojunction. Figure 1 (d) shows the surface scanning electron microscope (SEM) image of the device, which had a regular shape and a contamination-free surface. The HRTEM characterized the interface of each layer of the device, as shown in Figure 1 (e). The interface of each layer of the device was clearly discernible and flat. Figure 1(f) shows the energy dispersive x-ray spectroscopy (EDS) of the device. The elements In, Se and S were uniformly distributed and no diffusion. Weak Sn elements signals was detected in the InSe layer, because Se and In are in adjacent positions in the periodic table, and the Sn-La peak overlaps with the In-Lβ peak, so the In-Lβ peak is sometimes mistaken for the Sn-L\alpha peak when detecting Sn element, so that it can be detected in the InSe layer. In fact, the Sn element was only detected in the bottom layer. All the above results indicate the successful fabrication of the high-quality SnS<sub>2</sub>/InSe heterojunction.

Photoelectric characteristics of the SnS<sub>2</sub>/InSe heterojunction photodetector was tested. Figure 2 (a) shows Schematic diagram of the device measure setup. Bias voltages were applied to the electrodes connected to the  $SnS_2$ . Gate voltage  $(V_g)$  were applied through the highly doped silicon substrate. Figure 2 (b) shows the output characteristic curves of the photodetector as the gate voltage varied from -60 V to 60 V under dark conditions. The inset was the output characteristic curves of SnS<sub>2</sub>. Source-drain current (I<sub>ds</sub>) increased with increasing gate voltage, indicating that the photodetector had effective gate voltage modulation. We thought that the nonlinear output curves of the SnS<sub>2</sub>/InSe photodetector is mainly due to the additional barrier of heterojunction<sup>[6]</sup>. Figure 2 (c) shows the transfer characteristic curves of the photodetector. As the gate voltage changed from -80 V to 80 V, the device switched from the insulating state to the

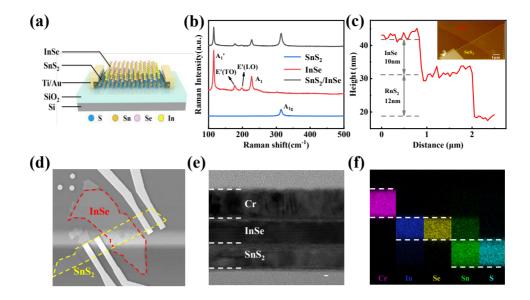


Fig. 1 (a) Schematic diagram of SnS₂/InSe heterostructure. (b) Raman spectrum of the single SnS₂, single InSe and their overlapped regions. (c) Height measurement maps of SnS₂ and InSe flakes in AFM, with insets showing the topographic views of SnS₂/InSe devices. (d) The SEM image of the SnS₂/InSe device. (e) HRTEM image, scale bar: 1 μm. (f) EDS image of each layer element. 图 1 (a) SnS₂/InSe 异质结构示意图,(b)单一 SnS₂、单一 InSe 以及重叠区域的拉曼光谱图,(c)AFM测量的 SnS₂和 InSe 薄片的高度图,插图为 SnS₂/InSe 器件的表面形貌,(d) SnS₂/InSe 器件的 SEM图像,(e) HRTEM图像,比例尺为 1 微米,(f)各层元素的 EDS图像

conducting state. Figure 2(d) shows a plot of the logarithmic curves of  $I_{\mbox{\tiny ds}}$  versus  $V_{\mbox{\tiny g}}$  when source-drain voltage  $(V_{ds})$  was 5 V, which characterized the switching ratio of the photodetector, and the switching ratio could reach 10<sup>5</sup>, which indicated the device had good current regulation capability. Figure 2(e) shows the output characteristic curves at different incident optical power densities under 365 nm illumination when the gate voltage was 0 V. I<sub>ds</sub> increased as the incident optical power density increased. Because with the increase of incident optical power density, more photogenerated carriers are generated in the channel, which lead to I<sub>ds</sub> increase. To examine the gate voltage modulation capability of the device more intuitively, we tested the transfer characteristic curves at V<sub>ds</sub>=5 V for different incident optical power densities. As shown in Figure 2(f), I<sub>ds</sub> increased with increasing gate voltage, indicating that the gate voltage could effectively modulate the channel current, and a large gate voltage drive more photogenerated carriers through the heterojunction. In addition, I<sub>ds</sub> increased with larger incident optical power density at the same gate voltage. Therefore, the large I<sub>ds</sub> current was a result of the combined modulation of the gate voltage and the incident optical power density.

To characterize the detection performance of the SnS<sub>2</sub>/InSe heterojunction photodetector under 365 nm illumination, the responsivity (R), specific detectivity (D\*), external quantum efficiency (EQE), and noise equivalent power (NEP) were calculated according to the following equations:

$$R = I_{ph} / (P_{in}A) \tag{1}$$

$$D^* = RA^{1/2} / (2eI_{dark})^{1/2}$$
 (2)

$$EQE = hcR\lambda^{-1}e^{-1} \tag{3}$$

$$NEP = A^{1/2}/D^* \tag{4}$$

where  $P_{in}$ , A, e, h, c, and  $\lambda$  are the incident optical power density, effective illuminated area, electron charge, Planck's constant, light speed, and incident light wavelength, respectively.

Figure 3 (a) shows the photocurrent  $I_{ph}$ - $V_s$  curves of the device. In increased first and then decreased with increasing gate voltage. Figure 3(b) shows the responsivity dependence of the gate voltage under various incident power densities at  $V_{ds} = 5$  V. The responsivity decreased with the increase of the incident optical power density. The highest responsivity of 813 A/W was obtained for the photodetector at  $P_{in}=1.269 \text{ mW/cm}^2$  and  $V_{in}=12.5 \text{ V}$ . The high responsivity of the device is due to the large number of photogenerated carriers generated in InSe under illumination, which are attracted to the SnS, layer by the gate voltage, thereby increasing the current in SnS<sub>2</sub> and improving the responsivity of the photodetector. Figure 3(c) shows the specific detectivity and noise equivalent power of the photodetector at  $V_{ds}=5$  V and  $V_{g}=0$  V. The specific detectivity reached a maximum value of 6.  $74\times10^{12}$  Jones at  $P_{\rm in}=1.269$  mW/cm<sup>2</sup> and the noise equivalent power reached a maximum value of 9.1×  $10^{-16}$  W/Hz<sup>1/2</sup> at  $P_{in}$ =16.75 mW/cm<sup>2</sup>. Figure 3 (d) shows the external quantum efficiency of the detector at V<sub>s</sub>= 12.5 V and  $V_{ds}$ =5 V, reaching a maximum of 2.8×10<sup>5</sup>% at  $P_{in} = 1.269 \text{ mW/cm}^2$ .

The response time is an important parameter for evaluating the performance of the photodetector. Figure 4 (a) showed the optical switching characteristic curve of

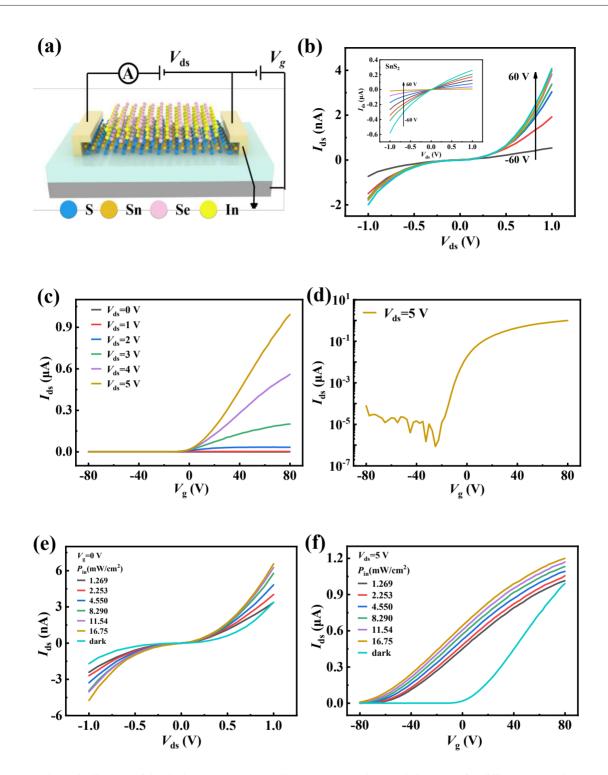


Fig. 2 (a) Schematic diagram of the device measure setup. (b)  $I_{ds}$ - $V_{ds}$  output characteristic curves for different gate voltages under dark conditions (The inset was the output characteristic curves of  $SnS_2$ ). (c)  $I_{ds}$ - $V_g$  transfer characteristic curves for different source-drain voltage under dark conditions. (d) The logarithmic curves of  $I_{ds}$ - $V_g$  when the source-drain voltage ( $V_{ds}$ ) is 5 V. (e) Output characteristic curves for different incident optical power densities under 365 nm illumination ( $V_g$ =0 V). (f) Transfer characteristic curves for different incident optical power densities under 365 nm illumination ( $V_g$ =5 V).

图 2 (a)器件测试示意图,(b)黑暗条件下不同栅极电压的 $I_a$ - $V_a$ 输出特性曲线(插图是  $SnS_2$ 的输出特性曲线),(c)黑暗条件下不同源漏电压的 $I_a$ - $V_a$ 转移特性曲线,(d)源漏电压( $V_a$ )为 SV 时  $I_a$ - $V_a$ 0的对数曲线,(e)在  $SS_2$ 0的输出特性曲线 ( $V_a$ 0的,在  $SS_2$ 0的输出特性曲线 ( $V_a$ 20),(f)在  $SS_2$ 0的加光照下不同入射光功率密度的转移特性曲线 ( $V_a$ 25)以

the  $SnS_2/InSe$  heterojunction photodetector under 365 nm illumination.  $I_{ds}$  did not decay significantly after several

times of optical switching, which indicated that the device had good stability. Figure 4(b) showed the response

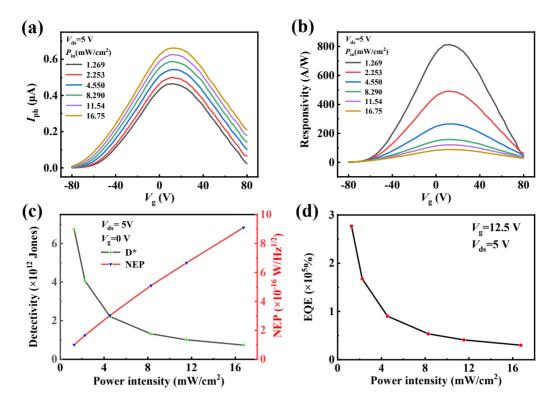


Fig. 3  $SnS_2$ /InSe heterojunction photodetector under 365 nm illumination. (a)  $I_{ph}$  as a function of incident optical power density and gate voltage ( $V_{ds}$ =5 V). (b) Responsivity as a function of gate voltage for different incident optical power densities. (c) Detectivity and noise equivalent power as functions of incident optical power density. (d) External quantum efficiency as a function of incident optical power density.

图 3 365nm光照下的  $SnS_2/InSe$  异质结光电探测器 (a) 不同人射光功率密度下的  $I_m$  与栅极电压的函数关系 ( $V_a$ =5 V),(b)不同人射光功率密度的响应度与栅极电压的函数关系,(c)探测率和噪声等效功率与人射光功率密度的函数关系,(d)外量子效率与人射光功率密度的函数关系

time of the detector, where the rise time was about 27 ms and the fall time was about 54 ms.

In addition, the device had a high optical responsivity and sensitivity from UV to NIR. Figure 5(a) showed the optical switching characteristic curves of the device under the incident wavelength of 365-965 nm.  $I_{\rm ds}$  of the device could change stably after several times of optical switching under different wavelength irradiation, which

proved that the device had good detection for broadband, and the response time was also stable at about 27 ms. What's more  $I_{\rm ds}$  was negatively correlated with wavelength, which is due to the fact that shorter wavelength light had higher energy. To verify the reliability of the experiment, we plotted the 2D image of the variation of responsivity with gate voltage at the same light power, as shown in Figure 5(b). The responsivity could also reach

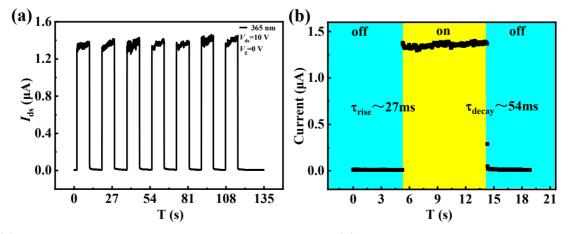


Fig. 4 (a) Optical switching characteristic curve under 365nm illumination. (b) Rise and fall time of photocurrent under 365nm illumination.

图 4 (a) 365nm 光照下的光开关特性曲线,(b) 365nm 光照下光电流的上升和下降时间

371 A/W at  $V_g$ =12.5 V under 965 nm illumination, which was much higher than other 2D broadband photodetectors [17-19]. The specific detectivity and noise equivalent power versus different incident light wavelengths were shown in Figure 5(c). The detectivity of the device were of the order of  $10^{12}$  Jones in the spectral range of 365-965 nm, and also 2-3 orders of magnitude higher than other 2D broadband photodetectors [10,19,20]. And the noise equivalent power were as low as  $10^{-16}$  W/Hz<sup>1/2</sup>. Figure 5(d) showed the external quantum efficiency versus the incident light wavelength, and a photovoltaic conversion capacity of 1.  $3\times10^5$ % was also obtained under 965 nm illumination. Therefore, our device had a good optical response performance in the 365-965 nm broadband spectral range.

To compare with other broadband heterojunction photodetectors, table 1 lists the results of other research groups [11, 21-28]. According to the comparison and analysis in the table. SnS<sub>2</sub>/InSe has excellent photoelectric performance, and it provides a direction for improving the comprehensive performance of the broadband photodetector.

## 3 Conclusion

In summary, we have successfully prepared a SnS<sub>2</sub>/

InSe photodetector. Using the wide band gap of InSe, the photodetector could detect the spectral range from UV to NIR. The device achieved a high responsivity of 813 A/W and 371 A/W under 365 nm and 965 nm illumination, respectively, which was higher than some other reported 2D broadband photodetectors. And the detectivity were the order of 10<sup>12</sup> Jones in the spectral range of 365-965 nm. The photodetector also had an external quantum efficiency of 1. 3×10<sup>5</sup>% and a response time of 27 ms under 965 nm illumination. The SnS<sub>2</sub>/InSe heterojunction photodetector provides a new way for developing broadband and high responsivity photodetectors.

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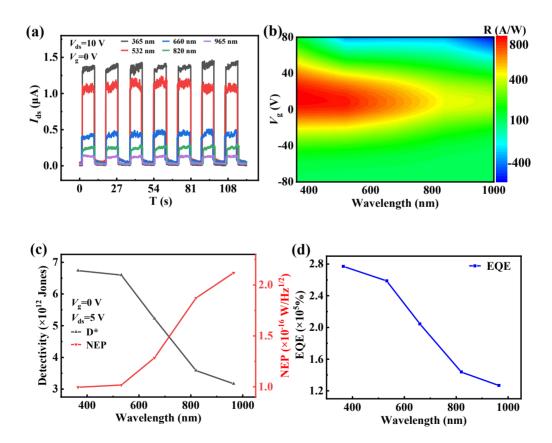


Fig. 5 (a) Optical switching characteristics under different incident light wavelength irradiation. (b) 2D images of responsivity as a function of gate voltage and incident light wavelength. (c) Detectivity and noise equivalent power as a function of incident light wavelength. (d) External quantum efficiency as a function of incident light wavelength.

图 5 (a)不同人射光波长照射下的光开关特性,(b)响应度与栅极电压和人射光波长的 2D 函数图像,(c)探测率和噪声等效功率与人射光波长的函数关系,(d)外量子效率与人射光波长的函数关系

Table 1.Comparison with the reported broadband photodetectors based on
2D material

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$\overline{A}$	与已报道的基于		带光电探测器的比较表
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Device	Laser λ (nm)	Responsivity (A/W) (MAX)	Rise/fall time (ms)	Detectivity (Jones)	Reference
MoS <sub>2</sub> /BP/Si	532-1550	22.3/153.4×10 <sup>-3</sup>	15×10 <sup>-3</sup>	$3.1\times10^{11}/2.13\times10^{9}$	[21]
quasi-2D tellurium	520-3000	$354/1.36\times10^3$	$52.3 \times 10^{-3} / 64 \times 10^{-3}$	$7.69 \times 10^{11}$	[22]
$\mathrm{Bi}_{2}\mathrm{Se}_{3}$	1456	2.7	500	$3.3 \times 10^{10}$	[23]
2D-Te	1000-3500	27	~200	$2.6 \times 10^{11}$	[24]
MoS <sub>2</sub> /Si	532-808	0.975	6.8/6.7	$6.56 \times 10^{11}$	[25]
$\mathrm{BP/MoS}_2$	280-660	77.16	>50	6.5×10 <sup>9</sup>	[26]
Graphene/BP	655-980	55.75/0.66	36		[27]
bismuth selenide	532-1064	300	$2\times10^3$	$7.5 \times 10^{9}$	[28]
SnSe/InSe	405-808	0.35	260/170	$5.8 \times 10^{10}$	[11]
SnS <sub>2</sub> /InSe	365-965	813/371	27/54	$6.74 \times 10^{12}$	This work

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